## P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

## DESCRIPTION

The $\mu$ PA1853 is a switching device which can be driven directly by a 4-V power source.
The $\mu$ PA1853 features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

## FEATURES

- Can be driven by a $4-\mathrm{V}$ power source
- Low on-state resistance
$\operatorname{Rds}(o n) 1=85 \mathrm{~m} \Omega$ MAX. $(\mathrm{VGs}=-10 \mathrm{~V}, \mathrm{ID}=-1.5 \mathrm{~A})$
$\operatorname{RDS}_{(o n) 2}=152 \mathrm{~m} \Omega \mathrm{MAX} .(\mathrm{VGS}=-4.5 \mathrm{~V}, \mathrm{ID}=-1.5 \mathrm{~A})$
$\operatorname{Rds}(o n) 3=180 \mathrm{~m} \Omega \mathrm{MAX} .(\mathrm{VGS}=-4.0 \mathrm{~V}, \mathrm{Id}=-1.5 \mathrm{~A})$


## ORDERING INFORMATION

| PART NUMBER | PACKAGE |
| :---: | :---: |
| $\mu$ PA1853GR-9JG | Power TSSOP8 |

## ABSOLUTE MAXIMUM RATINGS ( $\mathrm{T}_{\mathrm{A}}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )

| Drain to Source Voltage | VDSs | -30 |
| :--- | :---: | :---: |
| Gate to Source Voltage | $\mathrm{V}_{\mathrm{GSS}}$ | $-20 /+5$ |
| Drain Current (DC) | $\mathrm{ID}(\mathrm{DC})$ | $\mp 2.5$ |
| Drain Current (pulse) $^{\text {Note1 }}$ | $\mathrm{ID}($ pulse $)$ | $\mp 10$ |
| Total Power Dissipation $^{\text {Note2 }}$ | $\mathrm{PT}_{\mathrm{T}}$ | 2.0 |
| Channel Temperature | $\mathrm{T}_{\text {ch }}$ | 150 |
| Storage Temperature | Tstg | -55 to +150 |



Notes 1. PW $\leq 10 \mu \mathrm{~s}$, Duty Cycle $\leq 1 \%$
2. Mounted on ceramic substrate of $5000 \mathrm{~mm}^{2} \times 1.1 \mathrm{~mm}$

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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ELECTRICAL CHARACTERISTICS (TA $=25^{\circ} \mathrm{C}$ )

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Drain Cut-off Current | Idss | V ds $=-30 \mathrm{~V}, \mathrm{~V}_{\mathrm{Gs}}=0 \mathrm{~V}$ |  |  | -10 | $\mu \mathrm{A}$ |
| Gate Leakage Current | IGss | $\mathrm{VGS}=\mp 20 \mathrm{~V}, \mathrm{~V}$ ds $=0 \mathrm{~V}$ |  |  | $\mp 10$ | $\mu \mathrm{A}$ |
| Gate Cut-off Voltage | VGS (off) | V DS $=-10 \mathrm{~V}, \mathrm{ld}=-1 \mathrm{~mA}$ | -1.0 | -1.7 | -2.5 | V |
| Forward Transfer Admittance | \| yts | | V DS $=-10 \mathrm{~V}, \mathrm{ID}=-1.5 \mathrm{~A}$ | 1 | 3.6 |  | S |
| Drain to Source On-state Resistance | Rds(on) 1 | $\mathrm{VGS}=-10 \mathrm{~V}, \mathrm{ID}=-1.5 \mathrm{~A}$ |  | 64 | 85 | $\mathrm{m} \Omega$ |
|  | Rds(on)2 | $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{ld}=-1.5 \mathrm{~A}$ |  | 114 | 152 | $\mathrm{m} \Omega$ |
|  | Rds(on)3 | $\mathrm{V}_{\mathrm{GS}}=-4.0 \mathrm{~V}, \mathrm{ld}=-1.5 \mathrm{~A}$ |  | 135 | 180 | $\mathrm{m} \Omega$ |
| Input Capacitance | Ciss | $\begin{aligned} & \mathrm{V} D \mathrm{DS}=-10 \mathrm{~V} \\ & \mathrm{VGS}=0 \mathrm{~V} \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ |  | 520 |  | pF |
| Output Capacitance | Coss |  |  | 200 |  | pF |
| Reverse Transfer Capacitance | Crss |  |  | 82 |  | pF |
| Turn-on Delay Time | td(on) | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=-10 \mathrm{~V} \\ & \mathrm{ID}_{\mathrm{D}}=-1.5 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}(\text { (on })}=-10 \mathrm{~V} \\ & \mathrm{R}_{\mathrm{G}}=10 \Omega \end{aligned}$ |  | 60 |  | ns |
| Rise Time | tr |  |  | 220 |  | ns |
| Turn-off Delay Time | $\mathrm{t}_{\text {(foff) }}$ |  |  | 800 |  | ns |
| Fall Time | tf |  |  | 620 |  | ns |
| Total Gate Charge | QG | $\begin{aligned} & \mathrm{VDD}=-24 \mathrm{~V} \\ & \mathrm{ID}=-2.5 \mathrm{~A} \\ & \mathrm{~V} \text { GS }=-10 \mathrm{~V} \end{aligned}$ |  | 12 |  | nC |
| Gate to Source Charge | Qgs |  |  | 2 |  | nC |
| Gate to Drain Charge | Qgd |  |  | 3 |  | nC |
| Diode Forward Voltage | $V_{\text {F(S-D }}$ | $\mathrm{IF}=2.5 \mathrm{~A}, \mathrm{VGs}=0 \mathrm{~V}$ |  | 0.73 |  | V |

## TEST CIRCUIT 1 SWITCHING TIME



Duty Cycle $\leq 1 \%$

TEST CIRCUIT 2 GATE CHARGE


## TYPICAL CHARACTERISTICS ( $\mathrm{T}_{\mathrm{A}}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ )






GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT


DRAIN TO SOURCE ON-STATE RESISTANCE vs.


DRAIN TO SOURCE ON-STATE RESISTANCE vs.




SOURCE TO DRAIN DIODE FORWARD VOLTAGE


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